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**Measuring systems**

Problem set n°12

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**Comparison of measured data**


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**Exercise 1 (Noise due to capacitive coupling)**

A signal of bandwidth  $B_p$  perturbs a stationary voltage by capacitive coupling, which we want to measure. The signal is then passed through a low-pass filter. We measure the effective value of the desired signal before filtering ( $U_{b,A}$ , with  $N_A$  samples) and after filtering ( $U_{b,B}$ , with  $N_B$  samples). Does filtering reduce the noise significantly (risk of error  $\alpha$ )?

Numeric data:

$$B_p \in [0.5; 100 \text{ kHz}]$$

$$U_{b,A} = 10 \text{ } \mu\text{V}$$

$$N_A = 10$$

$$\alpha = 1 \text{ } \text{‰}$$

$$U_{b,B} = 3 \text{ } \mu\text{V}$$

$$N_B = 20$$

**Exercise 2 (Asymmetric amplifier)**

We want to amplify a stationary voltage  $U$  (value known *a priori*) using an asymmetric amplifier with gain  $A$  that generates a noise  $\Phi_n$  with bandwidth  $B_n$  in output (values provided by the manufacturer). Moreover, the temperature interferes on the output offset of the amplifier as a consequence of  $\varepsilon_{\Delta T}$  (reference temperature  $T_{ref}$  of 25 °C). We measure this output voltage with a voltmeter, which provides a signal averaged over  $N$  values.

- Calculate the average experimental voltage as a function of temperature and the standard deviation of the output voltage.
- What is the appropriate temperature range if we want to prove that the offset is not a systematic error with an error risk  $\alpha$ ?

Numerical data:

$$\Phi_n = 100 \text{ } \mu\text{V}/\sqrt{\text{Hz}}$$

$$B_n = [0; 100 \text{ kHz}]$$

$$N = 20$$

$$A = 60 \text{ dB}$$

$$U = 1 \text{ mV}$$

$$\varepsilon_{\Delta T} = 0.3 \text{ mV}/^\circ\text{C}$$